Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/526,565	NAGHIAN, SIAMAK
Examiner	**Art Unit**
Pablo N. Tran	2618

SEARCHED

Class	Subclass	Date	Examiner
370	238	07/28/07	
	338		
	252		
	254		
	255		
	328		
	386		
	229		
	230		
	235		
	256		
	310.1-313		
	389-393		
	432		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East / West	07/28/07	

Search Notes (continued)	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/526,565	NAGHIAN, SIAMAK	
	Examiner	Art Unit	
	Pablo N. Tran	2618	

SEARCHED			
Class	Subclass	Date	Examiner
455	403	07/26/07	pnt
	422		
	427-430		
	432-440		
	445		
	456-457		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR